IRF450 JANTX2N6770 JANTXV2N6770

500V, N-CHANNEL

REPETITIVE AVALANCHE AND dv/dt RATED HEXFET[®]TRANSISTORS THRU-HOLE (TO-204AA)

Product Summary

ISR HiRe

An Infineon Technologies Company

Part Number	BV _{DSS}	RDS(on)	I _D
IRF450	500V	0.400Ω	12A

Description

HEXFET[®] MOSFET technology is the key to IR Hirel advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high trans conductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Hermetically Sealed
- Simple Drive Requirements
- ESD Rating: Class 3A per MIL-STD-750, Method 1020

Symbol	Parameter	Value	Units	
$I_{D1} \textcircled{0} V_{GS} = 10V, T_C = 25^{\circ}C$ Continuous Drain Current $I_{D2} \textcircled{0} V_{GS} = 10V, T_C = 100^{\circ}C$ Continuous Drain Current		12		
		7.75	А	
I _{DM} @T _C = 25°C	Pulsed Drain Current ①	48		
P _D @T _C = 25°C	Maximum Power Dissipation	150	W	
	Linear Derating Factor	1.2	W/°C	
V _{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy ②	8.0	mJ	
I _{AR}	Avalanche Current ①	12	А	
E _{AR}	Repetitive Avalanche Energy ①	15	mJ	
dv/dt	Peak Diode Recovery ③	3.5	V/ns	
T _J Operating Junction and		-55 to + 150		
T _{STG}	Storage Temperature Range	-55 10 + 150	°C	
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)		
	Weight	11.5 (Typical)	g	

Absolute Maximum Ratings

For footnotes refer to the page 2.





Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	500			V	$V_{GS} = 0V, I_{D} = 1.0mA$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.78		V/°C	Reference to 25°C, I_D = 1.0mA
R _{DS(on)}				0.4	Ω	V _{GS} = 10V, I _{D2} = 7.75A ④
	Static Drain-to-Source On-Resistance			0.5		V _{GS} = 10V, I _{D1} = 12A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Gfs	Forward Transconductance	5.5			S	V _{DS} = 15V, I _{D2} = 7.75A ④
I _{DSS}	Zero Gate Voltage Drain Current			25		V_{DS} = 400V, V_{GS} = 0V
				250	μA	V_{DS} = 400V, V_{GS} = 0V, T_{J} =125°C
I _{GSS}	Gate-to-Source Leakage Forward			100	nA	V _{GS} = 20V
	Gate-to-Source Leakage Reverse			-100		V _{GS} = -20V
Q_G	Total Gate Charge	55		120		I _{D1} = 12A
Q_{GS}	Gate-to-Source Charge	5.0		19	nC	V _{DS} = 250V
Q_{GD}	Gate-to-Drain ('Miller') Charge	27		70		V _{GS} = 10V
t _{d(on)}	Turn-On Delay Time			35		V _{DD} = 250V
tr	Rise Time			190	20	I _{D1} = 12A
t _{d(off)}	Turn-Off Delay Time			170	ns	R _G = 2.35Ω
t _f	Fall Time			130		V _{GS} = 10V
Ls +L _D	Total Inductance		6.1		nЦ	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package)
C _{iss}	Input Capacitance		2700			V _{GS} = 0V
C _{oss}	Output Capacitance		600		pF	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		240			<i>f</i> = 1.0MHz

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)			12	^	
I _{SM}	Pulsed Source Current (Body Diode) ①			48	A	
V _{SD}	Diode Forward Voltage			1.7	V	T _J = 25°C,I _S = 12A, V _{GS} = 0V④
t _{rr}	Reverse Recovery Time			1600	ns	T_{J} = 25°C,I _F = 12A,V _{DD} \leq 30V
Q _{rr}	Reverse Recovery Charge			14	μC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}+L_{D}$)				

Thermal Resistance

Symbol	Parameter	Min.	Тур.	Max.	Units
$R_{ ext{ heta}JC}$	Junction-to-Case			0.83	°C/M
R _{0JA}	Junction-to-Ambient (Typical socket mount)			30	°C/W

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- \odot $~V_{\text{DD}}$ = 50V, starting T_{J} = 25°C, L= 0.111mH, Peak I_L = 12A, V_{GS} = 10V.
- $I_{SD} \leq 12A$, di/dt $\leq 130A/\mu s$, $V_{DD} \leq 500V$, $T_J \leq 150^{\circ}C$. Suggested R_G =2.35 Ω
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%





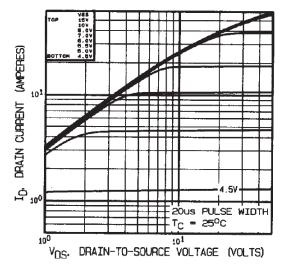


Fig 1. Typical Output Characteristics

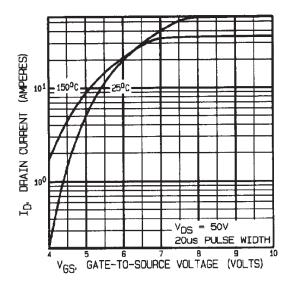


Fig 3. Typical Transfer Characteristics

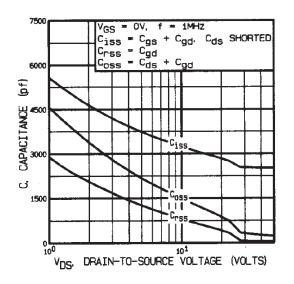


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

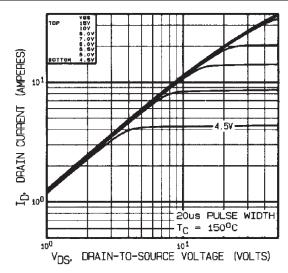


Fig 2. Typical Output Characteristics

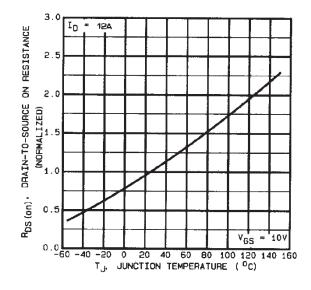
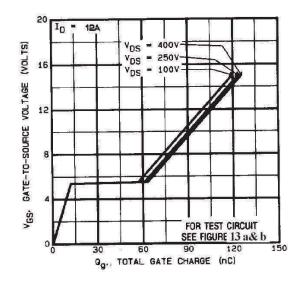


Fig 4. Normalized On-Resistance Vs. Temperature







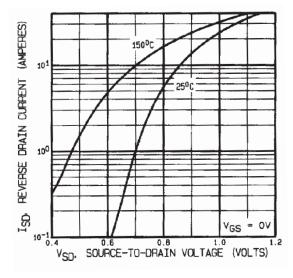


Fig 7. Typical Source-Drain Diode Forward Voltage

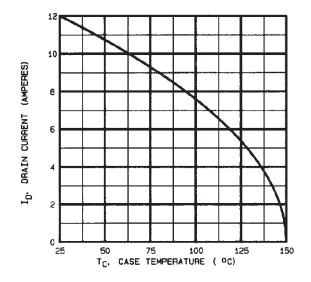


Fig 9. Maximum Drain Current Vs. Case Temperature

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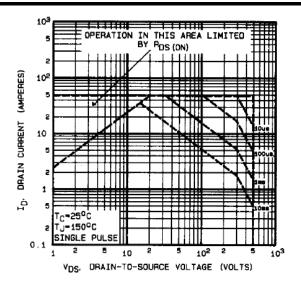


Fig 8. Maximum Safe Operating Area

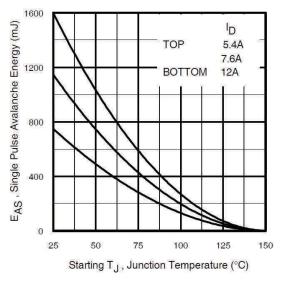


Fig 10. Maximum Avalanche Energy Vs. Drain Current

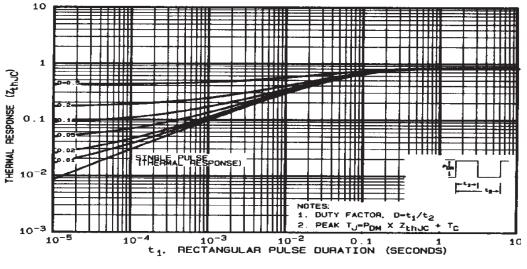


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



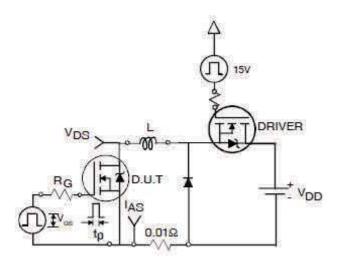


Fig 12a. Unclamped Inductive Test Circuit

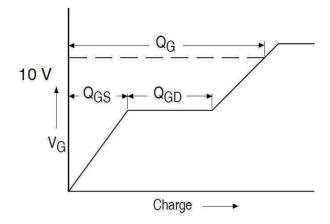


Fig 13a. Gate Charge Waveform

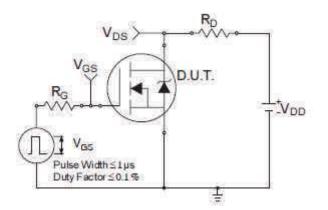
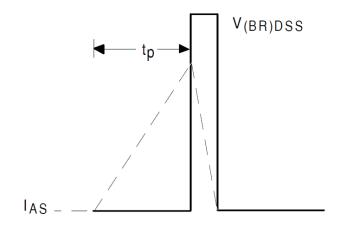
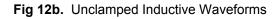
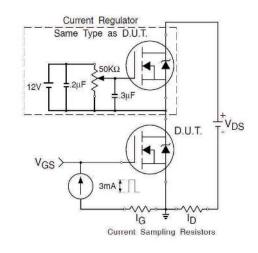
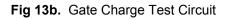


Fig 14a. Switching Time Test Circuit









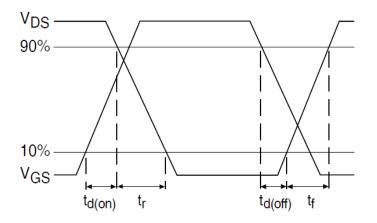
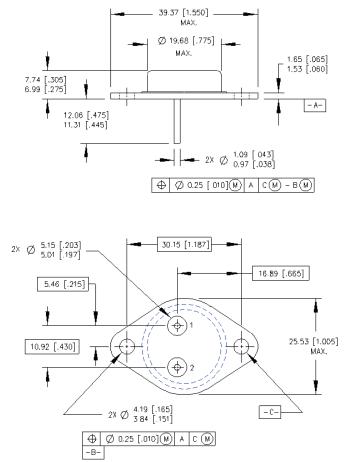


Fig 14b. Switching Time Waveforms



Case Outline and Dimensions - TO-204AA (Modified TO-3)



	PIN ASSIGNMENTS	
HEXFET	<u>SCHOTTKY</u>	<u>IGBT</u>
1 - SOURCE 2 - GATE 3 - DRAIN (CASE)	1 - ANODE 1 2 - ANODE 2 3 - COMMON CATHOD (CASE)	1 - GATE 2 - EMITTER 3 - COLLECTOR (CASE)

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M 1982 2. CONTROLLING DIMENSION : INCH.
- 3. DIMENSIONS ARE SHOWN IN MILIMETERS [INCHES] 4. OUTLINE CONFORMS TO JEDEC OUTLINE TO -204-AA

liKe 2**R** An Infineon Technologies Company

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